48 20E

47 1 1A1

46 1 1A2

45 GND

44 🛮 1A3

43 1 1A4

42 V_{CC}

41 2A1

40 2A2

39 **∏** GND

38 T 2A3

37 2A4

36**∏** 3A1

35 3A2

34 GND

33 II 3A3 32 3A4

31 V_{CC}

30 🛮 4A1

29 II 4A2

28 GND

27 1 4A3

26**∏** 4A4

25 3OE

DGG OR DL PACKAGE

(TOP VIEW)

1OE

1Y1 **1**2

1Y2 **[**]3

GND Π_4

1Y3 **1**5

1Y4 **[**]6

V_{CC} **□**7

2Y1 **[**8

2Y2 🛮 9

GND II 10

2Y3 II 11

2Y4 112

3Y1 **∏**13

3Y2 | 14

GND ∏15

3Y4 **1**17

4Y1 **[**] 19

4Y2 1 20

GND [21]

4Y3 **1**22

4Y4 **1**23

 Π_{24}

4OE

3Y3 **I** 16

 V_{CC} 18

- **Member of the Texas Instruments** Widebus™ Family
- **EPIC** ™ (Enhanced-Performance Implanted **CMOS) Submicron Process**
- **ESD Protection Exceeds 2000 V Per** MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0
- Latch-Up Performance Exceeds 250 mA Per JEDEC Standard JESD-17
- **Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors**
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink **Small-Outline (DGG) Packages**

description

This 16-bit buffer/driver is designed for 2.3-V to 3.6-V V_{CC} operation.

The SN74ALVCH16240 is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. It provides inverting outputs and symmetrical active-low output-enable (OE) inputs.

The SN74ALVCH16240 is available in TI's shrink small-outline (DL) and thin shrink small-outline (DGG) packages, which provide twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

To ensure the high-impedance state during power up or power down, $\overline{\sf OE}$ should be tied to ${\sf V}_{\sf CC}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16240 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (EACH 4-BIT BUFFER)

INP	JTS	OUTPUT
ŌĒ	Α	Y
L	Н	L
L	L	Н
Н	X	Z



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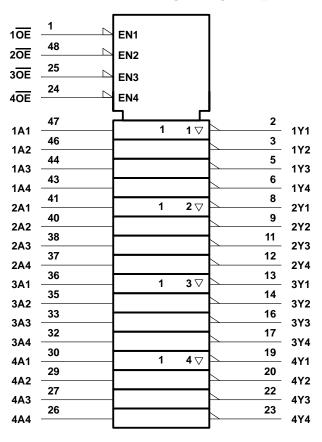
STRUMENTS

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SCES045A - JULY 1995 - REVISED JULY 1996

logic symbol[†]

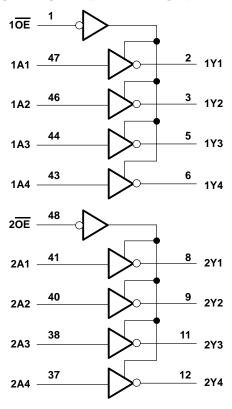
logic diagram (positive logic)

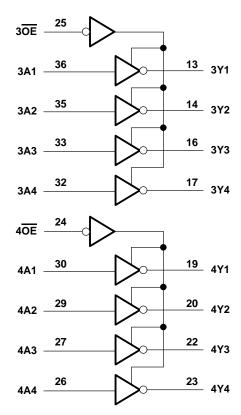


[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 4.6 V
Input voltage range, V _I (see Note 1)	0.5 V to 4.6 V
Output voltage range, V _O (see Notes 1 and 2)	\dots -0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through each V _{CC} or GND	±100 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 3): DGG packa	age0.85 W
DL package	e 1.2 W
Storage temperature range, T _{stg}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the *ABT Advanced BiCMOS Technology Data Book*.



recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
VCC	Supply voltage	2.3	3.6	V		
	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		1.7			
VIH	High-level input voltage	V _{CC} = 2.7 V to 3.6 V	2		V	
V	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V	
VIL		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V	
٧ _I	Input voltage		0	VCC	V	
VO	Output voltage		0	VCC	V	
I _{OH} H		V _{CC} = 2.3 V		-12		
	High-level output current	V _{CC} = 2.7 V		-12	12 mA	
		V _{CC} = 3 V		-24		
l _{OL}		V _{CC} = 2.3 V		12		
	Low-level output current	V _{CC} = 2.7 V		12		
		V _{CC} = 3 V		24		
$\Delta t/\Delta v$	Input transition rise or fall rate		0	10	ns/V	
T _A	Operating free-air temperature		-40	85	°C	

NOTE 4: Unused control inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAI	PARAMETER TEST CONDITIONS		v _{cc} †	MIN	TYP‡	MAX	UNIT		
		I _{OH} = -100 μA		MIN to MAX	VCC-0).2			
		$I_{OH} = -6 \text{ mA},$ $V_{IH} = 1.7 \text{ V}$		2.3 V	2				
\ _{\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\}			V _{IH} = 1.7 V	2.3 V	1.7			V	
VOH		$I_{OH} = -12 \text{ mA}$	V _{IH} = 2 V	2.7 V	2.2				
			V _{IH} = 2 V	3 V	2.4				
		$I_{OH} = -24 \text{ mA},$	V _{IH} = 2 V	3 V	2				
		I _{OL} = 100 μA		MIN to MAX			0.2	V	
		$I_{OL} = 6 \text{ mA},$	$V_{IL} = 0.7 V$	2.3 V			0.4		
VOL		la. 42 mA	V _{IL} = 0.7 V	2.3 V			0.7		
		I _{OL} = 12 mA	V _{IL} = 0.8 V	2.7 V			0.4		
		I _{OL} = 24 mA,	V _{IL} = 0.8 V	3 V			0.55		
Iį		$V_I = V_{CC}$ or GND		3.6 V			±5	μΑ	
		V _I = 0.7 V		2.3 V	45				
		V _I = 1.7 V		2.3 V	-45				
I _{I(hold)}		V _I = 0.8 V		3 V	75			μΑ	
		V _I = 2 V		3 V	-75				
		V _I = 0 to 3.6 V		3.6 V			±500		
loz		$V_O = V_{CC}$ or GND		3.6 V			±10	μΑ	
Icc		$V_I = V_{CC}$ or GND,	I _O = 0	3.6 V			40	μΑ	
Δlcc		One input at V _{CC} – 0.6 V,	Other inputs at V _{CC} or GND	3 V to 3.6 V			750	μΑ	
C	Control inputs	Vi = Vo o or GND		3.3 V		3		n.E	
Ci	Data inputs	$V_I = V_{CC}$ or GND		3.3 V		6		pF	
Co	Outputs	$V_O = V_{CC}$ or GND		3.3 V		7		pF	

[†] For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

[‡] Typical values are measured at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



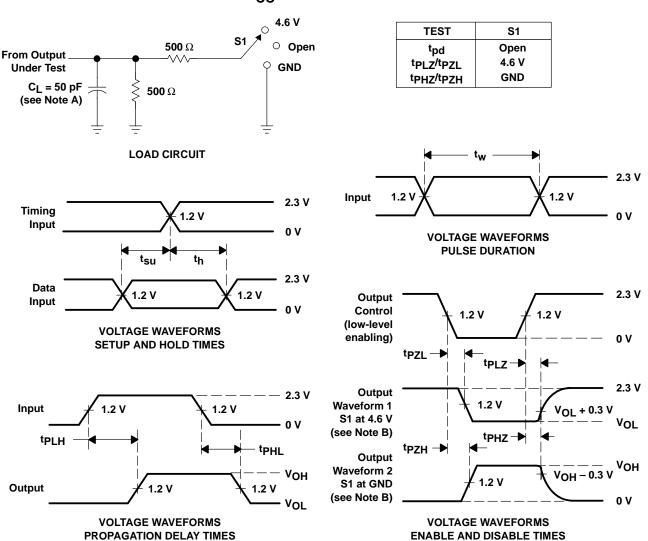
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
	(INFOT)		MIN	MAX	MIN	MAX	MIN	MAX	
t _{pd}	А	Υ	1	5.9		5.3	1	3.9	ns
t _{en}	ŌĒ	Υ	1	6.9		6.1	1	5	ns
t _{dis}	ŌĒ	Υ	1.5	5.6		4.8	1	4.4	ns

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER			TEST CONDITIONS	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT
				TYP	TYP	
C . Dower discination conscitones	Outputs enabled	C. FO. F. 4 40 MILE	16	19	pF	
Cpd	C _{pd} Power dissipation capacitance	Outputs disabled	$C_L = 50 \text{ pF}, f = 10 \text{ MHz}$	4	5	рг

PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.5 V \pm 0.2 V

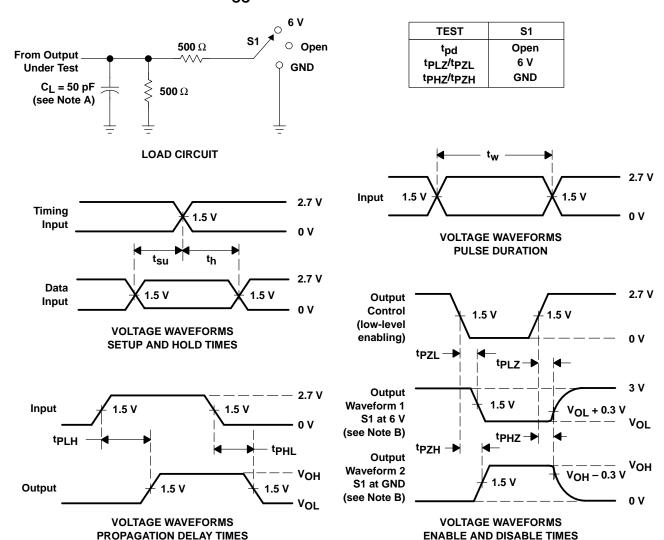


- NOTES: A. C_I includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \,\Omega$, $t_f \leq 2.5 \,\text{ns}$, $t_f \leq 2.5 \,\text{ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpl 7 and tpHZ are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.7 V AND 3.3 V \pm 0.3 V



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \ \Omega$, $t_f \leq 2.5 \ ns$, $t_f \leq 2.5 \ ns$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpl 7 and tpH7 are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

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